

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10824874	BALLEW ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Geib, Benjamin	2181

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
712	10	1/26/2010	PG
710	316	1/26/2010	PG

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search	1/26/2010	PG
NPL search (IEEE Xplore and Google Scholar)	1/26/2010	PG
Inventor name search	1/26/2010	PG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
712	10	1/26/2010	PG

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